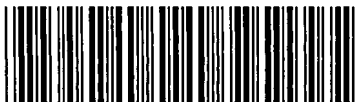


Search Notes (continued)

Application/Control No.

10/646,708

Examiner

Patrick J. Lee

Applicant(s)/Patent under
Reexamination

ECKER ET AL.

Art Unit

2878

SEARCHED

Class	Subclass	Date	Examiner
250	227.14, 227.16	9/13/2007	PL
385	10, 12	9/13/2007	PL
385	13, 37	9/13/2007	PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	9/13/2007	PL